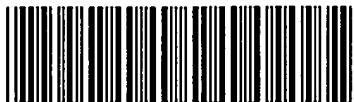


## **Search Notes**



**Application/Control No.**

10/660,629

Examiner

Tod T. Van Roy

**Applicant(s)/Patent under  
Reexamination**

KANEKO ET AL.

## **Art Unit**

2828

## **INTERFERENCE SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
please see attached search history	6/26/05	PM
Spoke with examiner James Merleit regarding answer directions	6/26/05	PM
Spoke with translator Steven Spar	6/26/05	PM
general class searches for radius of curvature and lens height relation	6/26/05	PM
general class searches for polarization	6/26/05	PM